

Notice of References Cited	Application/Control No. 10/840,060		Applicant(s)/Patent Under Reexamination DEAK ET AL.	
	Examiner Rita Mitra		Art Unit 1653	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0208558 A1	09-2005	Venter et al.	435/006
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Venter et al. Publication number US20050208558A1, SEQ ID NO: 142 sequence alignment result 2, Database: Published_Applications_NA_Main, US 11-097-143-1103
	V	
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	X	

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